

# ICE7N60FP N-Channel Enhancement Mode MOSFET

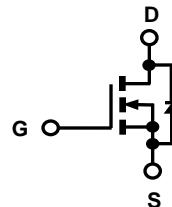
 RoHS  
 compliant  
 2011/65/EU

 HALOGEN  
 FREE

Product Summary			
$I_D$	$T_A=25^\circ\text{C}$	7A	Max
$V_{(\text{BR})\text{DSS}}$	$I_D=250\mu\text{A}$	600V	Min
$r_{\text{DS}(\text{on})}$	$V_{\text{GS}}=10\text{V}$	0.52Ω	Typ
$Q_g$	$V_{\text{DS}}=480\text{V}$	21nC	Typ

## Features

- Low  $r_{\text{DS}(\text{on})}$
- Ultra Low Gate Charge
- High dv/dt capability
- High Unclamped Inductive Switching (UIS) capability
- High peak current capability
- Increased transconductance performance
- Optimized design for high performance power systems



**T0220 Full-PAK**  
**Isolated (T0-220)**

ICEMOS AND ITS SISTER COMPANY 3D SEMI OWN THE FUNDAMENTAL PATENTS FOR SUPERJUNCTION MOSFETS. THE MAJORITY OF THESE PATENTS HAVE 17 to 20 YEARS OF REMAINING LIFE. THIS PORTFOLIO HAS GRANTED PATENTS ISSUED IN USA, CHINA, KOREA, JAPAN, TAIWAN & EUROPE.

**Maximum ratings<sup>b</sup>**, at  $T_j=25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	$I_D$	$T_c=25^\circ\text{C}$	7	A
Pulsed drain current	$I_D$ , pulse	$T_c=25^\circ\text{C}$	21	A
Avalanche energy, single pulse	$E_{\text{AS}}$	$I_D=3.5\text{A}$	170	mJ
Avalanche current, repetitive	$I_{\text{AR}}$	limited by $T_j\text{max}$	3.5	A
MOSFET dv/dt ruggedness	dv/dt	$V_{\text{DS}}=480\text{V}$ , $I_D=7\text{A}$ , $T_j=125^\circ\text{C}$	50	V/ns
Gate source voltage	$V_{\text{GS}}$	Static	$\pm 20$	V
		AC ( $f>1\text{Hz}$ )	$\pm 30$	
Power dissipation	$P_{\text{tot}}$	$T_c=25^\circ\text{C}$	35	W
Operating and storage temperature	$T_j$ , $T_{\text{stg}}$		-55 to +150	°C
Mounting torque		M 2.5 screws	50	Ncm

a When mounted on 1inch square 2oz copper clad FR-4

b Preliminary Data Sheet – Specifications subject to change

Parameter	Symbol	Conditions	Values			Unit
			Min	Typ	Max	

**Thermal characteristics**

Thermal resistance, junction-case <sup>a</sup>	$R_{thJC}$		-	-	3.5	°C/W
Thermal resistance, junction-ambient <sup>a</sup>	$R_{thJA}$	leaded	-	-	80	
Soldering temperature, wave soldering only allowed at leads	$T_{sold}$	1.6mm (0.063in.) from case for 10 s	-	-	260	°C

**Electrical characteristics** <sup>b</sup>, at  $T=25^{\circ}\text{C}$ , unless otherwise specified

**Static characteristics**

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}, I_D=250\mu\text{A}$	600	-	-	V
Gate threshold voltage	$V_{GS(\text{th})}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2.1	3	3.9	
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=600\text{V}, V_{GS}=0\text{V}, T_j=25^{\circ}\text{C}$	-	0.1	1	$\mu\text{A}$
		$V_{DS}=600\text{V}, V_{GS}=0\text{V}, T_j=150^{\circ}\text{C}$	-	-	100	
Gate source leakage current	$I_{GSS}$	$V_{GS}=\pm 20\text{ V}, V_{DS}=0\text{V}$	-	-	100	nA
Drain-source on-state resistance	$R_{DS(\text{on})}$	$V_{GS}=10\text{V}, I_D=3.5\text{A}, T_j=25^{\circ}\text{C}$	-	0.52	0.60	$\Omega$
		$V_{GS}=10\text{V}, I_D=3.5\text{A}, T_j=150^{\circ}\text{C}$	-	1.3	-	
Gate resistance	$R_G$	$f=1\text{ MHZ}, \text{open drain}$	-	6	-	$\Omega$

**Dynamic characteristics**

Input capacitance	$C_{iss}$	$V_{GS}=0\text{ V}, V_{DS}=25\text{ V}, f=1\text{ MHz}$	-	635	-	pF
Output capacitance	$C_{oss}$		-	365	-	
Reverse transfer capacitance	$C_{rss}$		-	6	-	
Transconductance	$g_{fs}$	$V_{DS}>2*I_D*R_{DS}, I_D=3.5\text{A}$	-	7	-	S
Turn-on delay time	$t_{d(on)}$	$V_{DS}=380\text{V}, V_{GS}=10\text{V}, I_D=7\text{A}, R_G=4\Omega \text{ (External)}$	-	6	-	ns
Rise time	$t_r$		-	3.5	-	
Turn-off delay time	$t_{d(off)}$		-	54	-	
Fall time	$t_f$		-	7	-	

<b>Parameter</b>	<b>Symbol</b>	<b>Conditions</b>	<b>Values</b>			<b>Unit</b>
			<b>Min</b>	<b>Typ</b>	<b>Max</b>	

**Gate charge characteristics**

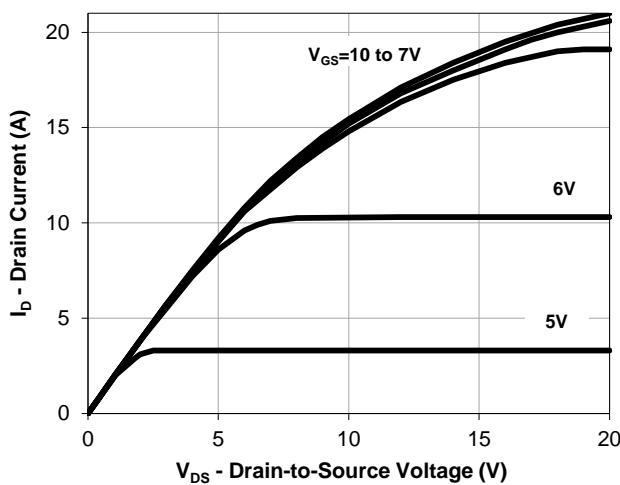
Gate to source charge	$Q_{gs}$	$V_{DS}=480\text{ V}, I_D=7\text{ A}, V_{GS}=0\text{ to }10\text{ V}$	-	4.6	-	nC
Gate to drain charge	$Q_{gd}$		-	6.4	-	
Gate charge total	$Q_g$		-	21	-	
Gate plateau voltage	$V_{plateau}$		-	5.5	-	

**Reverse Diode**

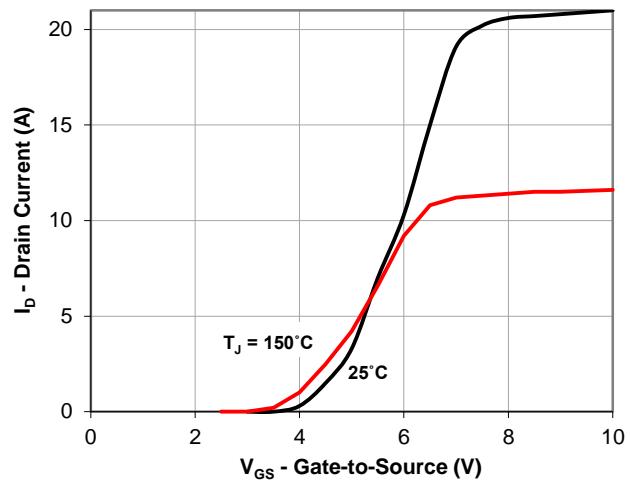
Diode forward voltage	$V_{SD}$	$V_{GS}=0\text{V}, I_S=I_F$	-	0.9	1.2	V
Reverse recovery time	$t_{rr}$	$V_{RR}=480\text{V}, I_S=I_F, d_iF/d_t=100\text{ A}/\mu\text{s}$	-	277	-	ns
Reverse recovery charge	$Q_{rr}$		-	2.6	-	$\mu\text{C}$
Peak reverse recovery current	$I_{rm}$		-	20	-	A



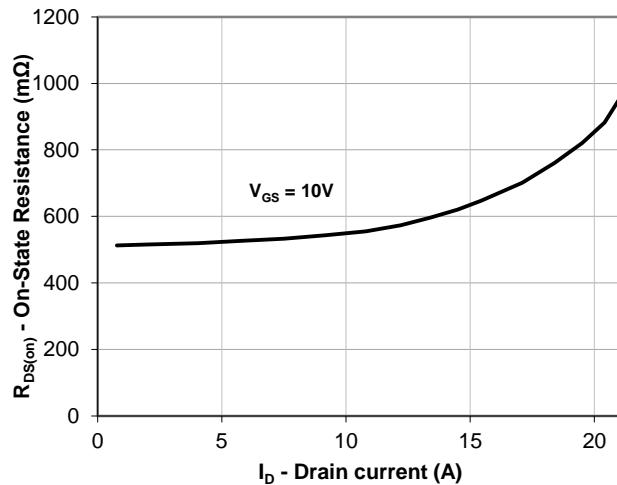
### Output Characteristics



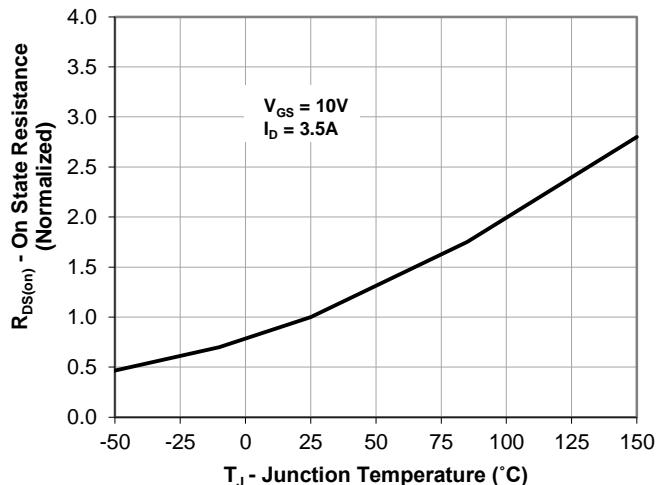
### Transfer Characteristics



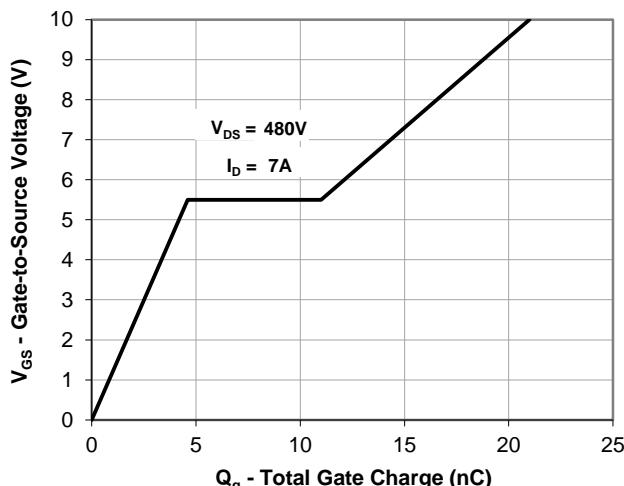
### On Resistance vs Drain Current



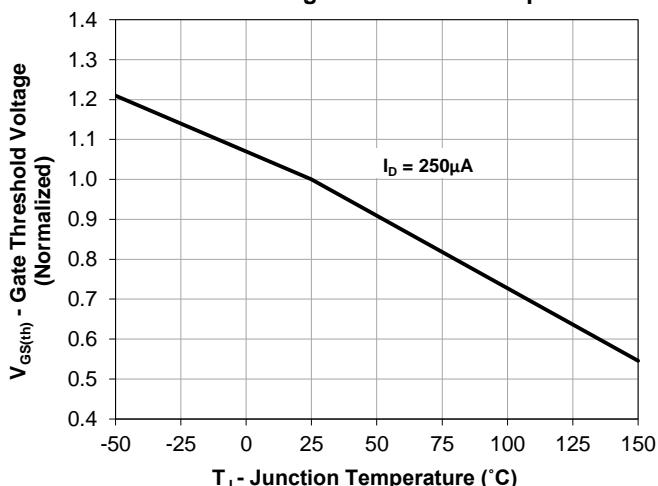
### On Resistance vs Junction Temperature

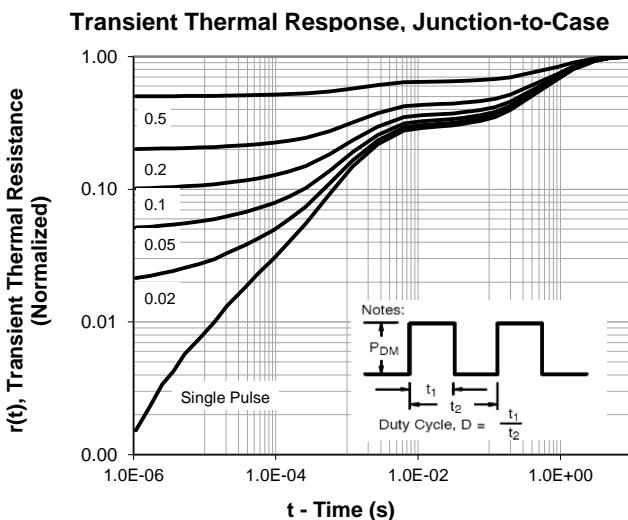
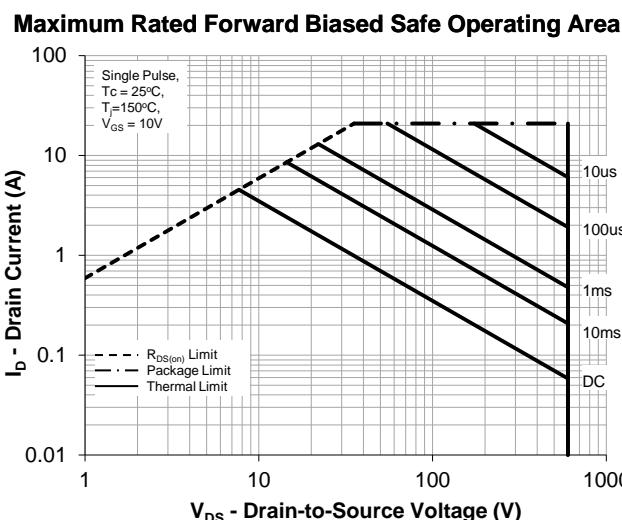
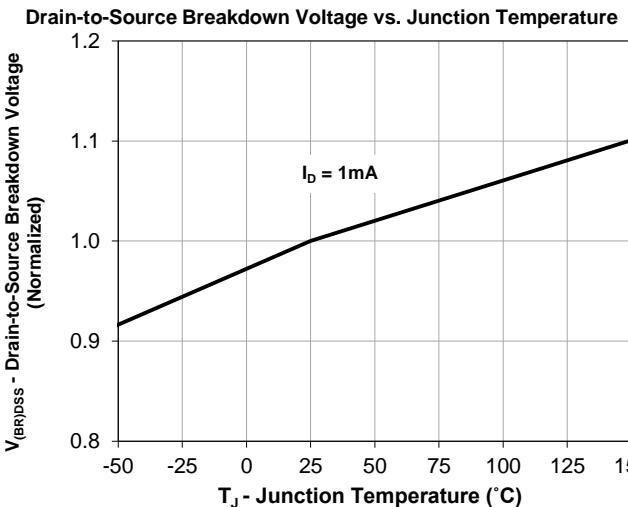
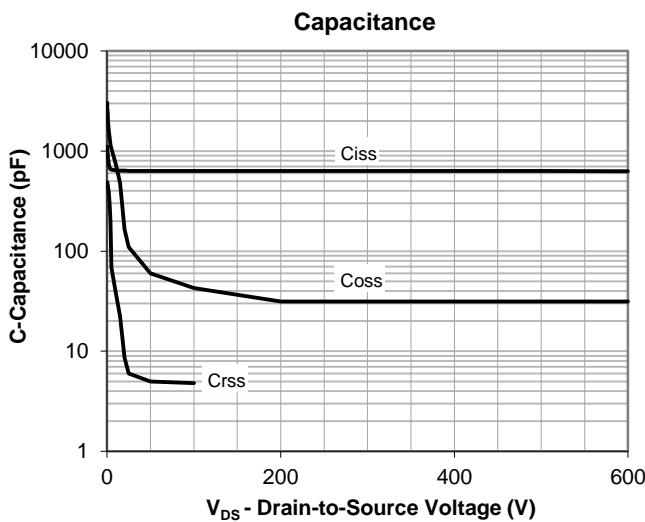


### Gate Charge



### Gate Threshold Voltage vs Junction Temperature

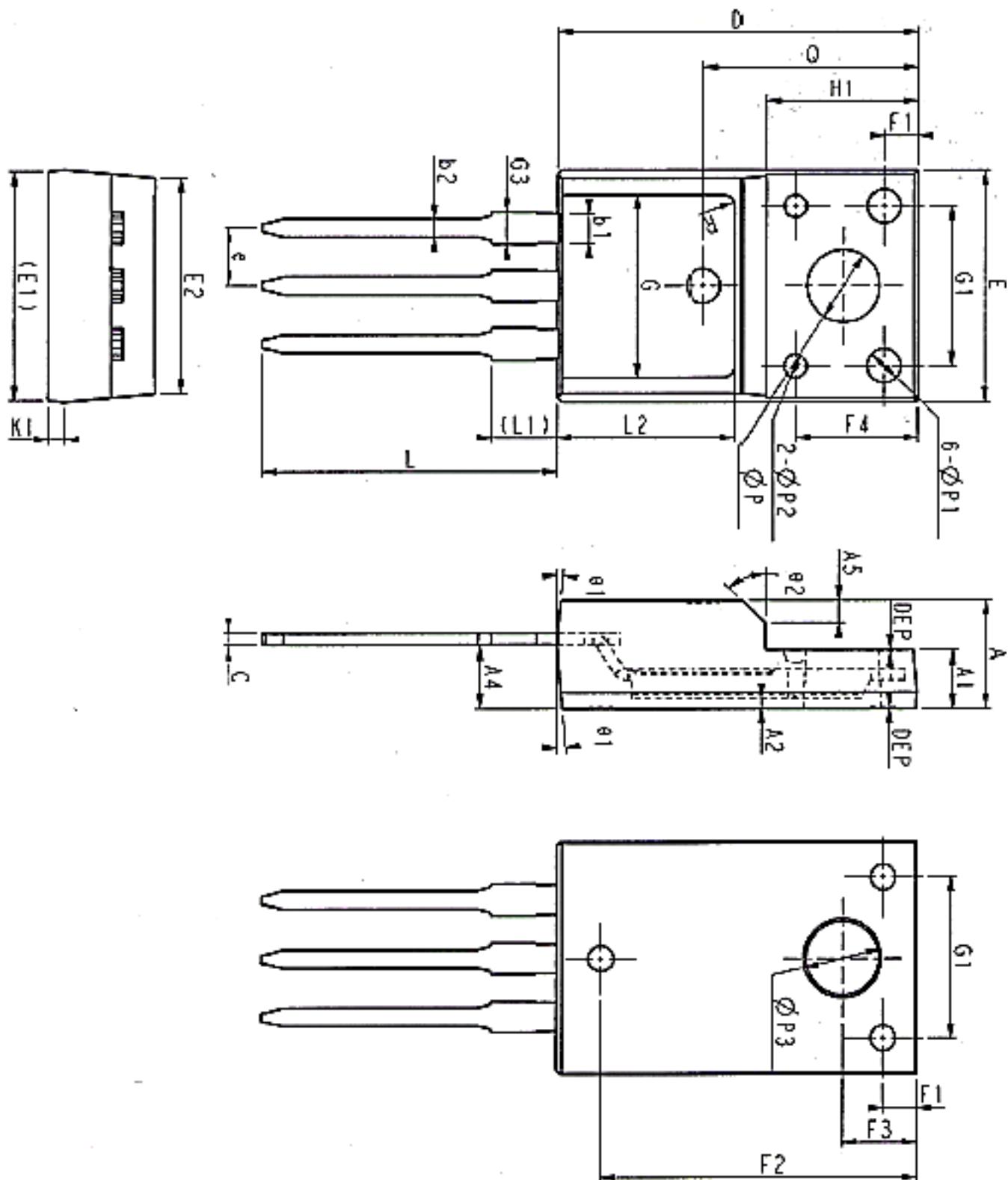






Icemos  
Cooler than cool

Preliminary Data Sheet  
**ICE7N60FP**



COMMON DIMENSIONS						
SYMBOL	MM			INCH		
	MIN	NOM	MAX	MIN	NOM	MAX
E	9.63	10.19	10.75	0.38	0.40	0.42
E1	9.94	10.04	10.14	0.39	0.40	0.40
E2	9.36	9.46	9.56	0.37	0.37	0.38
A	4.30	4.60	4.90	0.17	0.18	0.19
A1	2.34	2.77	3.20	0.092	0.11	0.126
A2	0.43	0.87	1.30	0.017	0.03	0.051
A4	2.51	2.72	2.93	0.10	0.11	0.12
A5	1.00REF			0.39REF		
c	0.33	0.54	0.75	0.013	0.021	0.030
D	15.67	15.9	16.13	0.617	0.626	0.635
Q	9.4REF			0.370REF		
H1	6.7REF			0.264REF		
E	2.54BSC			0.100BSC		
ΦP	3.18REF			0.125REF		
L	12.78	13.25	13.72	0.50	0.52	0.54
L1	2.83	3.25	3.67	0.11	0.13	0.14
L2	7.70	7.80	7.90	0.30	0.31	0.31
ΦP1	1.4	1.5	1.6	0.055	0.059	0.063
ΦP2	1.15	1.2	1.25	0.045	0.047	0.049
ΦP3	3.45REF			0.136REF		
θ1	3°	5°	7°	3°	5°	7°
θ2	-	45°	-	-	45°	-
DEP	0.05	0.10	0.15	0.002	0.004	0.006
F1	1.0	1.50	2.0	0.039	0.059	0.079
F2	13.8	13.90	14.0	0.543	0.547	0.551
F3	3.20	3.30	3.40	0.126	0.130	0.134
F4	5.30	5.40	5.50	0.209	0.213	0.217
G	7.80	8.00	8.20	0.307	0.315	0.323
G1	6.05	6.58	7.10	0.238	0.259	0.280
G3	1.25	1.35	1.45	0.049	0.053	0.057
b1	1.23	1.31	1.38	0.048	0.051	0.054
b2	0.61	0.78	0.94	0.024	0.031	0.037
K1	0.65	0.70	0.75	0.026	0.028	0.030
R	0.50REF			0.020REF		

## **ICEMOS SUPERJUNCTION PATENT PORTFOLIO**

### **ICEMOS GRANTED PATENTS**

**US7,429,772  
US7,439,178  
US7,446,018  
US7,579,607  
US7,723,172  
US7,795,045  
US7,846,821  
US7,944,018  
US8,012,806  
US8,030,133**

### **3D SEMI PATENTS LICENSED TO ICEMOS**

**US7,041,560B2  
US7,023,069B2  
US7,364,994  
US7,227,197B2  
US7,304,944B2  
US7,052,982B2  
US7,339,252  
US7,410,891  
US7,439,583  
US7,227,197B2  
US6,635,906  
US6,936,867  
US7,015,104  
US9,109,110  
US7,271,067  
US7,354,818  
US7,052,982,  
US7,199,006B2**

**Note:** additional patents in China, Korea, Japan, Taiwan, Europe have also been granted to IceMOS and 3D Semi for Superjunction MOSFETs with 70 additional Patent applications in process in the USA and the above listed countries.

## Marking Information

**YY** = Last two digits of the year

**WW** = Work week calendar on Icemos  
subcon assembly & test house

\* = Initial for Icemos subcon  
assembly and test house

**XXXX** = Wafer Lot ID

**00** = may be used for wafer ID in a  
special case.

= "00" is used unless specified.

**ICE7N60** = ICE is Icemos logo and 7N60  
is a designated device part number

